


<b>Search Notes</b>  	<b>Application/Control No.</b>  10595112	<b>Applicant(s)/Patent Under Reexamination</b>  KONDOU ET AL.
	<b>Examiner</b>  Tianjie Chen	<b>Art Unit</b>  2627

SEARCHED			
Class	Subclass	Date	Examiner
720	734		
	738		
	739		
360	133		
369	291	10/10/2008	TJ

SEARCH NOTES		
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